

March 2015

FDD3860

N-Channel PowerTrench® MOSFET 100V, 29A, 36m Ω

Features

- Max $r_{DS(on)} = 36m\Omega$ at $V_{GS} = 10V$, $I_D = 5.9A$
- High performance trench technology for extremely low r_{DS(on)}
- 100% UIL tested
- RoHS Compliant

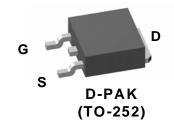


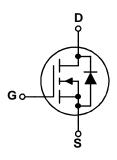
General Description

This N-Channel MOSFET is rugged gate version of Fairchild Semiconductor's advanced Power Trench[®] process. This part is tailored for low $r_{DS(on)}$ and low Qg figure of merit, with avalanche ruggedness for a wide range of switching applications.

Applications

- DC-AC Conversion
- Synchronous Rectifier





MOSFET Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter		Ratings	Units	
V _{DS}	Drain to Source Voltage		100	V	
V _{GS}	Gate to Source Voltage			±20	V
I _D	Drain Current -Continuous (Silicon limited)	Drain Current -Continuous (Silicon limited) T _C = 25°C		29	
	-Continuous	T _A = 25°C	(Note 1a)	6.2	Α
	-Pulsed			60	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	121	mJ
D	Power Dissipation	T _C = 25°C		69	W
P_{D}	Power Dissipation	T _A = 25°C	(Note 1a)	3.1	VV
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	1.8	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	40	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDD3860	FDD3860	D-PAK (TO-252)	13"	16mm	2500 units

Electrical Characteristics $T_J = 25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics					
BV_{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	100			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I _D = 250μA, referenced to 25°C		98		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 80V, V_{GS} = 0V$			1	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA

On Characteristics

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 250\mu A$	2.5	3.8	4.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250\mu\text{A}$, referenced to 25°C		-11.4		mV/°C
	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 5.9A$		29	36	mΩ
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 5.9A, T_J = 125$ °C		51	64	11152
9 _{FS}	Forward Transconductance	$V_{DS} = 10V, I_D = 5.9A$		20		S

Dynamic Characteristics

C _{iss}	Input Capacitance	\\\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	1310	1740	pF
C _{oss}	Output Capacitance	$V_{DS} = 50V, V_{GS} = 0V,$ $f = 1MHz$	100	130	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1101112	45	70	pF
R_{q}	Gate Resistance	f = 1MHz	1.6		Ω

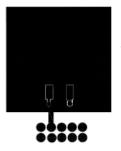
Switching Characteristics

t _{d(on)}	Turn-On Delay Time			16	29	ns
t _r	Rise Time	$V_{DD} = 50V, I_{D} = 5.9A,$ $V_{GS} = 10V, R_{GEN} = 6\Omega$		10	21	ns
t _{d(off)}	Turn-Off Delay Time	V _{GS} = 10V, K _{GEN} = 012		24	39	ns
t _f	Fall Time			7	15	ns
Qg	Total Gate Charge at 10V	V 50V I 50A		22	31	nC
Q _{gs}	Gate to Source Charge	$V_{DD} = 50V, I_D = 5.9A$		7.1		nC
Q_{gd}	Gate to Drain "Miller" Charge			6.3		nC

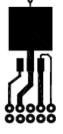
Drain-Source Diode Characteristics

V	Source to Drain Diode Forward Voltage	$V_{GS} = 0V, I_S = 2.0A$ (Note 2)	0.7	1.2	\/
Source to Drain Diode Forward Voltage		$V_{GS} = 0V, I_S = 5.9A$ (Note 2)	0.8	1.3	v
t _{rr}	Reverse Recovery Time	I _F = 5.9A, di/dt = 100A/μs	34	55	ns
Q _{rr}	Reverse Recovery Charge	1F = 3.9A, αι/αι = 100A/μS	40	64	nC

R_{0JC} is guaranteed by design while R_{0JA} is determined by the user's board design.



a) 40°C/W when mounted on a 1 in² pad of 2 oz copper



b) 96°C/W when mounted on a minimum pad.

- 2: Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%. 3: Starting T $_J$ = 25°C, L = 3mH, I $_{AS}$ = 9A, V $_{DD}$ = 100V, V $_{GS}$ = 10V.

Typical Characteristics T_J = 25°C unless otherwise noted

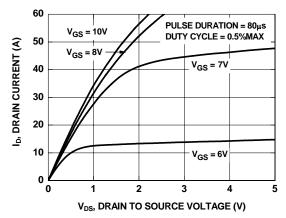


Figure 1. On-Region Characteristics

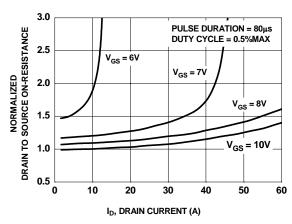


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

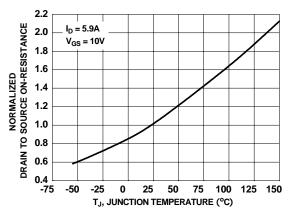


Figure 3. Normalized On-Resistance vs Junction Temperature

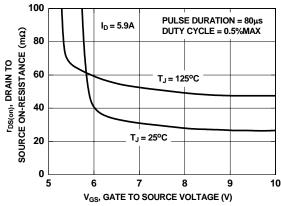


Figure 4. On-Resistance vs Gate to Source Voltage

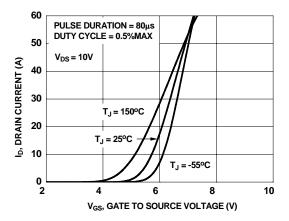


Figure 5. Transfer Characteristics

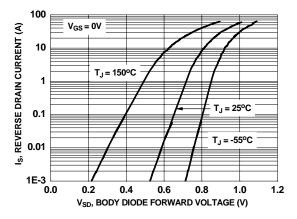


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics T_J = 25°C unless otherwise noted

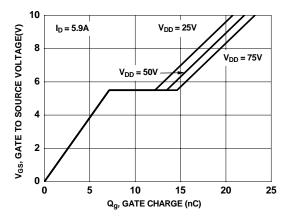


Figure 7. Gate Charge Characteristics

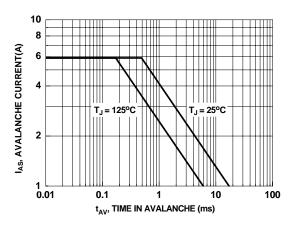


Figure 9. Unclamped Inductive Switching Capability

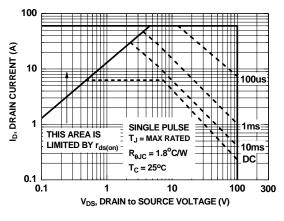


Figure 11. Forward Bias Safe Operating Area

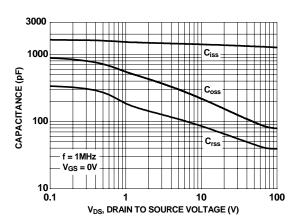


Figure 8. Capacitance vs Drain to Source Voltage

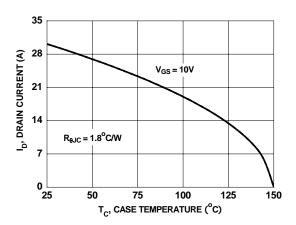


Figure 10. Maximum Continuous Drain Current vs Case Temperature

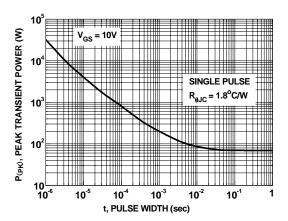


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics T_J = 25°C unless otherwise noted

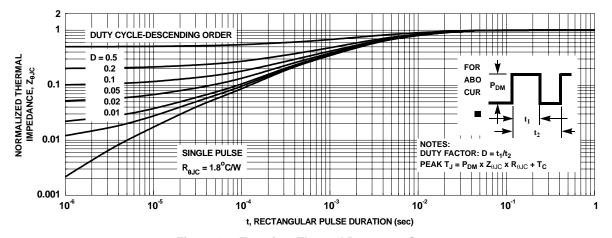


Figure 13. Transient Thermal Response Curve

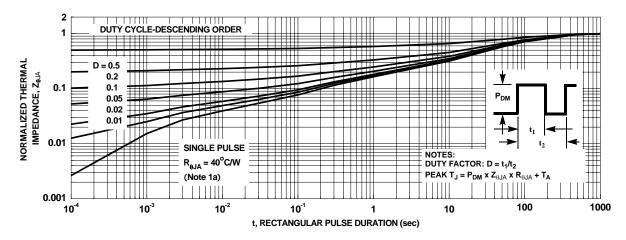


Figure 14. Transient Thermal Response Curve

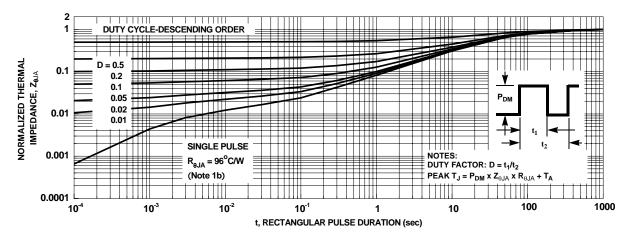
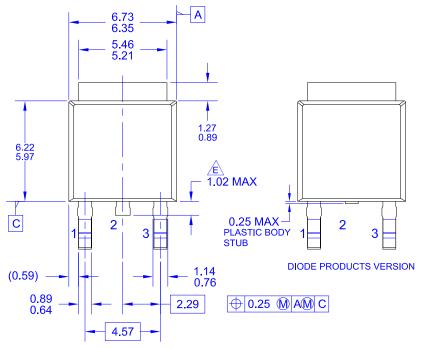
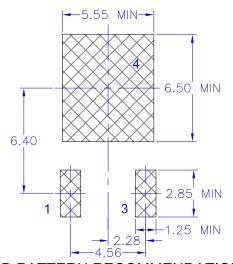
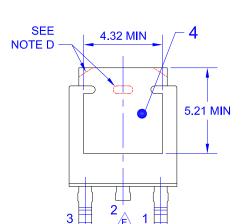


Figure 15. Transient Thermal Response Curve



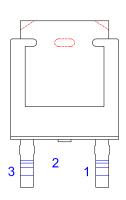


LAND PATTERN RECOMMENDATION

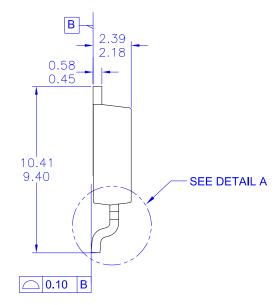


NON-DIODE PRODUCTS VERSION





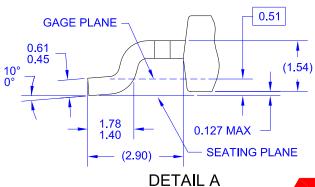
DIODE PRODUCTS VERSION



NOTES: UNLESS OTHERWISE SPECIFIED

- A) THIS PACKAGE CONFORMS TO JEDEC, TO-252,
- ISSUE C, VARIATION AA.

 B) ALL DIMENSIONS ARE IN MILLIMETERS.
 C) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-2009.
- D) SUPPLIER DEPENDENT MOLD LOCKING HOLES OR CHAMFERED CORNERS OR EDGE PROTRUSION.
- E) TRIMMED CENTER LEAD IS PRESENT ONLY FOR DIODE PRODUCTS F) DIMENSIONS ARE EXCLUSSIVE OF BURSS,
 - MOLD FLASH AND TIE BAR EXTRUSIONS.
- G) LAND PATTERN RECOMENDATION IS BASED ON IPC7351A STD TO228P991X239-3N.
- H) DRAWING NUMBER AND REVISION: MKT-TO252A03REV10



(ROTATED -90°) SCALE: 12X







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Definition of Terms

Definition of Terms					
Datasheet Identification	Product Status	Definition			
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.			
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.			
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Rev. 174

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Contact Us:

> Address:

401 Building No.5, JiuGe Business Center, Lane 2301, Yishan Rd Minhang District, Shanghai , China

> Sales:

Direct +86 (21) 6401-6692

Email amall@ameya360.com

QQ 800077892

Skype ameyasales1 ameyasales2

Customer Service :

Email service@ameya360.com

Partnership :

Tel +86 (21) 64016692-8333

Email mkt@ameya360.com